Data sheet acquired from Harris Semiconductor SCHS133C

August 1997 - Revised May 2003

# High-Speed CMOS Logic BCD-to-Decimal Decoders (1 of 10)

#### **Features**

- . Buffered Inputs and Outputs
- Typical Propagation Delay: 12ns at V<sub>CC</sub> = 5V, C<sub>L</sub> = 15pF, T<sub>A</sub> = 25°C
- Fanout (Over Temperature Range)
- Wide Operating Temperature Range . . . -55°C to 125°C
- Balanced Propagation Delay and Transition Times
- Significant Power Reduction Compared to LSTTL Logic ICs
- HC Types
  - 2V to 6V Operation
  - High Noise Immunity: N<sub>IL</sub> = 30%, N<sub>IH</sub> = 30% of V<sub>CC</sub> at V<sub>CC</sub> = 5V
- HCT Types
  - 4.5V to 5.5V Operation
  - Direct LSTTL Input Logic Compatibility,
    V<sub>IL</sub>= 0.8V (Max), V<sub>IH</sub> = 2V (Min)
  - CMOS Input Compatibility, I<sub>I</sub>  $\leq$  1 $\mu$ A at V<sub>OL</sub>, V<sub>OH</sub>

## Description

The 'HC42 and CD74HCT42 BCD-to-Decimal Decoders utilize silicon-gate CMOS technology to achieve operating speeds similar to LSTTL decoders with the low power consumption of standard CMOS integrated circuits. These devices have the capability of driving 10 LSTLL loads and are compatible with the standard LS logic family. One of ten outputs (low on select) is selected in accordance with the BCD input. Non-valid BCD inputs result in none of the outputs being selected (all outputs are high).

#### Ordering Information

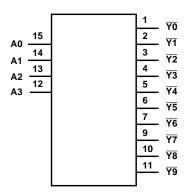
PART NUMBER	TEMP. RANGE (°C)	PACKAGE
CD54HC42F3A	-55 to 125	16 Ld CERDIP
CD74HC42E	-55 to 125	16 Ld PDIP
CD74HC42M	-55 to 125	16 Ld SOIC
CD74HCT42E	-55 to 125	16 Ld PDIP

#### **Pinout**

**CD74HC42** (PDIP, SOIC) CD74HCT42 (PDIP) **TOP VIEW** Y0 1 16 V<sub>CC</sub> **Y1** 2 15 A0 Y2 3 14 A1 **Y3** 4 13 A2 Y4 5 12 A3 **Y5** 6 11 Y9 10 Y8 Y6 7 9 Y7 GND 8

CD54HC42 (CERDIP)

# Functional Diagram



# TRUTH TABLE

	INP	UTS			OUTPUTS											
А3	A2	<b>A</b> 1	Α0	Y0	<u>Y1</u>	<u> 72</u>	<u> 73</u>	<u>¥4</u>	<u> </u>	<u>¥6</u>	<u>77</u>	<u>78</u>	<u>Y9</u>			
L	L	L	L	L	Н	Н	Н	Н	Н	Н	Н	Н	Н			
L	L	L	Н	Н	L	Н	Н	Н	Н	Н	Н	Н	Н			
L	L	Н	L	Н	Н	L	Н	Н	Н	Н	Н	Н	Н			
L	L	Н	Н	Н	Н	Н	L	Н	Н	Н	Н	Н	Н			
L	Н	L	L	Н	Н	Н	Н	L	Н	Н	Н	Н	Н			
L	Н	L	Н	Н	Н	Н	Н	Н	L	Н	Н	Н	Н			
L	Н	Н	L	Н	Н	Н	Н	Н	Н	L	Н	Н	Н			
L	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н	L	Н	Н			
Н	L	L	L	Н	Н	Н	Н	Н	Н	Н	Н	L	Н			
Н	L	L	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н	L			
Н	L	Н	L	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н			
Н	L	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н			
Н	Н	L	L	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н			
Н	Н	L	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н			
Н	Н	Н	L	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н			
Н	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н			

H = High Voltage Level, L = Low Voltage Level

#### **Absolute Maximum Ratings**

#### DC Supply Voltage, V<sub>CC</sub> . . . . . -0.5V to 7V DC Input Diode Current, I<sub>IK</sub> DC Output Diode Current, $I_{OK}$ DC Output Source or Sink Current per Output Pin, IO For $V_O > -0.5V$ or $V_O < V_{CC} + 0.5V$ ......±25mA

#### **Thermal Information**

Thermal Resistance (Typical, Note 1)	$\theta_{JA}$ (°C/W)
E (PDIP) Package	. 67
M (SOIC) Package	
Maximum Junction Temperature	150 <sup>o</sup> C
Maximum Storage Temperature Range	-65°C to 150°C
Maximum Lead Temperature (Soldering 10s)	300°C
(SOIC - Lead Tips Only)	

#### **Operating Conditions**

Temperature Range (T <sub>A</sub> ) .............-55 <sup>0</sup> C to 125 <sup>0</sup>	C,
Supply Voltage Range, V <sub>CC</sub>	
HC Types2V to 6	٧
HCT Types	ί۷
DC Input or Output Voltage, V <sub>I</sub> , V <sub>O</sub> 0V to V <sub>C</sub>	СС
Input Rise and Fall Time	
2V	x)
4.5V 500ns (Ma	x)
6V	x)

CAUTION: Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

#### NOTE:

1. The package thermal impedance is calculated in accordance with JESD 51-7.

#### **DC Electrical Specifications**

		TEST CONDITIONS		v <sub>cc</sub>	25°C			-40°C T	O 85°C	-55°C TO 125°C			
PARAMETER	SYMBOL	V <sub>I</sub> (V)	I <sub>O</sub> (mA)	(V)	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNITS	
HC TYPES													
High Level Input	V <sub>IH</sub>	-	-	2	1.5	-	-	1.5	-	1.5	-	V	
Voltage				4.5	3.15	•	-	3.15	-	3.15	-	V	
				6	4.2	•	-	4.2	-	4.2	-	V	
Low Level Input	V <sub>IL</sub>	-	-	2	-	-	0.5	-	0.5	-	0.5	V	
Voltage				4.5	-	-	1.35	-	1.35	-	1.35	V	
				6	-	-	1.8	-	1.8	-	1.8	V	
High Level Output	V <sub>OH</sub>	V <sub>IH</sub> or V <sub>IL</sub>	-0.02	2	1.9	-	-	1.9	-	1.9	-	V	
Voltage CMOS Loads			-0.02	4.5	4.4	-	-	4.4	-	4.4	-	V	
			-0.02	6	5.9	-	-	5.9	-	5.9	-	V	
High Level Output	7		-	-	-	-	-	-	-	-	-	V	
Voltage TTL Loads			-4	4.5	3.98	-	-	3.84	-	3.7	-	V	
			-5.2	6	5.48	-	-	5.34	-	5.2	-	V	
Low Level Output	V <sub>OL</sub>	V <sub>IH</sub> or V <sub>IL</sub>	0.02	2	-	-	0.1	-	0.1	-	0.1	V	
Voltage CMOS Loads			0.02	4.5	-	-	0.1	-	0.1	-	0.1	V	
			0.02	6	-	-	0.1	-	0.1	-	0.1	V	
Low Level Output	1		-	-	-	-	-	-	-	-	-	V	
Voltage TTL Loads			4	4.5	-	-	0.26	-	0.33	-	0.4	V	
112 20000			5.2	6	-	-	0.26	-	0.33	-	0.4	V	
Input Leakage Current	II	V <sub>CC</sub> or GND	-	6	-	-	±0.1	-	±1	-	±1	μΑ	
Quiescent Device Current	Icc	V <sub>CC</sub> or GND	0	6	-	-	8	-	80	-	160	μΑ	

# DC Electrical Specifications (Continued)

		TEST CONDITIONS		V <sub>CC</sub>	25°C			-40°C TO 85°C		-55°C TO 125°C		
PARAMETER	SYMBOL	V <sub>I</sub> (V)	I <sub>O</sub> (mA)	(V)	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNITS
HCT TYPES	-						-	-	-	-	-	
High Level Input Voltage	V <sub>IH</sub>	-	-	4.5 to 5.5	2	-	-	2	-	2	-	V
Low Level Input Voltage	V <sub>IL</sub>	-	-	4.5 to 5.5	-	-	0.8	-	0.8	-	0.8	V
High Level Output Voltage CMOS Loads	Voн	V <sub>IH</sub> or V <sub>IL</sub>	-0.02	4.5	4.4	-	-	4.4	-	4.4	-	V
High Level Output Voltage TTL Loads			-4	4.5	3.98	-	-	3.84	-	3.7	-	V
Low Level Output Voltage CMOS Loads	V <sub>OL</sub>	V <sub>IH</sub> or V <sub>IL</sub>	0.02	4.5	-	-	0.1	-	0.1	-	0.1	V
Low Level Output Voltage TTL Loads			4	4.5	-	-	0.26	-	0.33	-	0.4	V
Input Leakage Current	lį	V <sub>CC</sub> and GND	0	5.5	-		±0.1	-	±1	-	±1	μΑ
Quiescent Device Current	Icc	V <sub>CC</sub> or GND	0	5.5	-	-	8	-	80	-	160	μА
Additional Quiescent Device Current Per Input Pin: 1 Unit Load	ΔI <sub>CC</sub> (Note 2)	V <sub>CC</sub> -2.1	-	4.5 to 5.5	-	100	360	-	450	-	490	μΑ

#### NOTE:

## **HCT Input Loading Table**

INPUT	UNIT LOADS
All	1

NOTE: Unit Load is  $\Delta I_{\hbox{CC}}$  limit specified in DC Electrical Table, e.g. 360µA max at 25°C.

# Switching Specifications Input $t_{r}$ , $t_{f} = 6$ ns

					25°C	25°C		-40°C TO 85°C		-55°C TO 125°C			
PARAMETER	SYMBOL	TEST CONDITIONS	V <sub>CC</sub> (V)	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNITS		
HC TYPES													
Propagation Delay,	t <sub>PLH</sub> , t <sub>PHL</sub>	C <sub>L</sub> = 50pF	2	-	-	150	-	190	-	225	ns		
Input to Y (Figure 1)			4.5	-	-	30	-	38	-	45	ns		
			6	-	-	26	-	33	-	38	ns		
Any Input to ₹	t <sub>PLH</sub> , t <sub>PHL</sub>	C <sub>L</sub> = 15pF	5	-	12	-	-	-	-	-	ns		
Output Transition Time	t <sub>TLH</sub> , t <sub>THL</sub>	C <sub>L</sub> = 50pF	2	-	-	75	-	95	-	110	ns		
(Figure 1)			4.5	-	-	15	-	19	-	22	ns		
			6	-	-	13	-	16	-	19	ns		
Input Capacitance	C <sub>IN</sub>	-	-	-	_	10	_	10	-	10	pF		

<sup>2.</sup> For dual-supply systems theoretical worst case ( $V_I$  = 2.4V,  $V_{CC}$  = 5.5V) specification is 1.8mA.

### Switching Specifications Input $t_r$ , $t_f = 6ns$ (Continued)

		TEST	V <sub>CC</sub> (V)	25°C			-40°C TO 85°C		-55°C TO 125°C				
PARAMETER	SYMBOL	CONDITIONS		MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNITS		
Power Dissipation Capacitance (Notes 3, 4)	C <sub>PD</sub>	-	5	-	65	-	-	-	-	-	pF		
HCT TYPES													
Propagation Delay, Input to Y (Figure 2)	t <sub>PLH</sub> , t <sub>PHL</sub>	C <sub>L</sub> = 50pF	4.5	-	-	35	-	44	-	53	ns		
Any Input to Y	t <sub>PLH</sub> , t <sub>PHL</sub>	C <sub>L</sub> = 15pF	5	-	14	-	-	-	-	-	ns		
Output Transition Time (Figure 2)	t <sub>TLH</sub> , t <sub>THL</sub>	C <sub>L</sub> = 50pF	4.5	-	-	15	-	19	-	22	ns		
Input Capacitance	C <sub>IN</sub>	-	-	-	-	10	-	10	-	10	pF		
Power Dissipation Capacitance (Notes 3, 4)	C <sub>PD</sub>	-	5	-	70	-	-	-	-	-	pF		

#### NOTES:

- 3.  $C_{\mbox{PD}}$  is used to determine the dynamic power consumption, per package.
- 4.  $P_D = V_{CC}^2 f_i (C_{PD} + C_L)$  where:  $f_i$  = Input Frequency,  $C_L$  = Output Load Capacitance,  $V_{CC}$  = Supply Voltage.

### Test Circuits and Waveforms

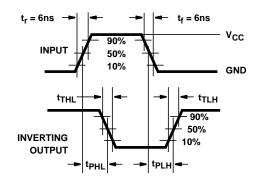


FIGURE 1. HC AND HCU TRANSITION TIMES AND PROPAGATION DELAY TIMES, COMBINATION LOGIC

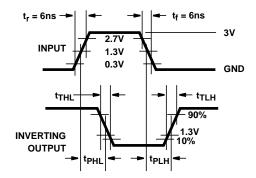


FIGURE 2. HCT TRANSITION TIMES AND PROPAGATION DELAY TIMES, COMBINATION LOGIC





6-Feb-2020

#### **PACKAGING INFORMATION**

Orderable Device	Status	Package Type	Package Drawing	Pins	_		Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking	Samples
	(1)		Drawing		Qty	(2)	(6)	(3)		(4/5)	
CD54HC42F3A	ACTIVE	CDIP	J	16	1	TBD	Call TI	N / A for Pkg Type	-55 to 125	5962-8682101EA CD54HC42F3A	Samples
CD74HC42E	ACTIVE	PDIP	N	16	25	Green (RoHS & no Sb/Br)	NIPDAU	N / A for Pkg Type	-55 to 125	CD74HC42E	Samples
CD74HC42M	ACTIVE	SOIC	D	16	40	Green (RoHS & no Sb/Br)	NIPDAU	Level-1-260C-UNLIM	-55 to 125	HC42M	Samples
CD74HCT42E	ACTIVE	PDIP	N	16	25	Green (RoHS & no Sb/Br)	NIPDAU	N / A for Pkg Type	-55 to 125	CD74HCT42E	Samples

(1) The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead/Ball Finish Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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## **PACKAGE OPTION ADDENDUM**

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#### OTHER QUALIFIED VERSIONS OF CD54HC42, CD74HC42:

Military: CD54HC42

NOTE: Qualified Version Definitions:

- Catalog TI's standard catalog product
- Military QML certified for Military and Defense Applications

# D (R-PDS0-G16)

### PLASTIC SMALL OUTLINE



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
- E. Reference JEDEC MS-012 variation AC.



# D (R-PDSO-G16)

# PLASTIC SMALL OUTLINE



- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



# 14 LEADS SHOWN



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. This package is hermetically sealed with a ceramic lid using glass frit.
- D. Index point is provided on cap for terminal identification only on press ceramic glass frit seal only.
- E. Falls within MIL STD 1835 GDIP1-T14, GDIP1-T16, GDIP1-T18 and GDIP1-T20.

# N (R-PDIP-T\*\*)

# PLASTIC DUAL-IN-LINE PACKAGE

16 PINS SHOWN



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).
- The 20 pin end lead shoulder width is a vendor option, either half or full width.



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